## Notice of References Cited

Application/Control No.	Applicant(s)/Pate	nt Under
09/863,233	Reexamination DEPAOLANTON	IO, JOSEPH
Examiner	Art Unit	
Alex H Chan	2633	Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,678,475 B1	01-2004	Turban et al.	398/79
	В	US-2002/0069275 A1 '	06-2002	Tindal, Glen D.	709/223
	С	US-6,583,901 B1	06-2003	Hung, Henry	398/79
	D	US-5,995,256	11-1999	Fee, John A.	398/34
	E	US-6,233,074 B1	05-2001	Lahat et al.	398/79
	F	US-5,663,819	09-1997	Lewis, Stephen P.	398/58
	G	US-2001/0012141 A1	08-2001	Takai et al.	359/110
	Н	US-6,377,725 B1	04-2002	Stevens et al.	385/24
	1	US-5,561,542	10-1996	Kosugi et al.	398/58
	J	US-6,154,273	11-2000	Suzuki, Yasuo	356/73.1
	К	US-6,344,910 B1	02-2002	Cao, Simon X. F.	398/34
	L	US-6,072,609	06-2000	Masuda, Hiroshi	398/27
	М	US-5,367,394	11-1994	Chuter et al.	398/33

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U			
	V			
	w			
	х			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.